

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination YAMAUCHI ET AL.	
		Examiner Thuy V. Tran	Art Unit 2821	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,761,605 B2	07-2004	Kado et al.	445/6
	B	US-6,666,738 B1	12-2003	Kado et al.	445/6
	C	US-6,373,195 B1	04-2002	Whang et al.	315/169.3
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	K	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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